

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/698,945	LEE ET AL.	
	Examiner	Art Unit	
	James D. Ewart	2683	

# SEARCHED

Class	Subclass	Date	Examiner
370	328	2/10/2006	JDE
	329		
	331		
	332		
	335		
	341-342		
	431		
	441		
	465		
455	62		
	63.1		
	67.11		
	423		
	424		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
same as	above	2/10/2006	JDE

## **Search Notes (continued)**



**Application/Control No.**

10/698,945

Examiner

James D. Ewart

**Applicant(s)/Patent under  
Reexamination**

LEE ET AL.

## **Art Unit**

2683

**SEARCHED**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
same as	above	2/10/2006	JDE

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**